

cherenkov telescope array



Sensitivity of the Cherenkov Telescope Array to a dark matter signal from the Galactic centre

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We gratefully acknowledge financial support from the agencies and organizations listed here: <u>http://www.cta-observatory.org/consortium_acknowledgments</u>

1. Shealing

Data analysis – "benchmark" setup

Template Fitting (3D analysis)

$$\left(\mu_{\rm K}\right)_k = \mu_k^{\rm CR} + \mu_k^{\rm GDE} + \Delta B_k + A^{\rm DM} \mu_k^{\rm DM}$$

Generic setup:

CTA Mock Data:

- Asimov data set
- CR + IEM
- spatial binning: 0.1°
- spectral binning: 54 bins (width corresponding to 2σ energy resolution of CTA) from [0.03, 100] TeV
- PS mask

Model Data:

- template preparation like mock data
- CR + IEM + DM
 - –> systematic uncertainty added via covariance matrix

$$(K_{\rm S})_{jj'} = \sigma_{\rm S}^2 \exp\left(-\frac{1}{2} \frac{\left\|\vec{r}_j - \vec{r}_{j'}\right\|^2}{\ell_{\rm S}^2}\right)$$

Implementation via python package swordfish [Edwards & Weniger; arXiv:1712.05401]



ICRC 2021, 12-23 July 2021

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Summary

We derive the CTA's sensitivity to a DM signal in the Galactic centre by

- defining the most promising data analysis approach (template-based analysis),
- studying the impact of instrumental systematic uncertainties in an agnostic manner (for a possible input of future CTA performance optimisation),
- quantifying the robustness of the expected limits with respect to uncertainties of astrophysical emission components like the interstellar emission
 - -> Will the measured interstellar emission at TeV energies match the current theoretical models?
 - -> Do we expect surprises in terms of TeV source populations?



CTA offers the opportunity to probe the uncharted territory of the WIMP parameter space beyond the thermal annihilation cross-section at the TeV scale!

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